Title:

Spherical nanoindentation stress-strain curves of commercially pure titanium and Ti-6Al-4V

Authors:

Jordan S. Weaver^{1,2}, Matthew W. Priddy², David L. McDowell², Surya R. Kalidindi²* ¹Center for Integrated Nanotechnologies, Los Alamos National Laboratory, Los Alamos, NM, USA ²George W. Woodruff School of Mechanical Engineering, Georgia Institute of Technology, Atlanta, GA, USA *Corresponding author. Tel.: +1 404 385 2886. E-mail address: surya.kalidindi@me.gatech.edu (S.R. Kalidindi). URL: http://mined.gatech.edu/

Abstract:

Spherical nanoindentation combined with electron back-scattered diffraction was employed to

characterize the grain-scale elastic and plastic anisotropy of single crystal alpha-Ti for

commercially pure (CP-Ti) and alloyed (Ti-64) titanium. In addition, alpha-beta Ti (single

colony) grains were characterized. The data set includes the nanoindentation force, displacement,

and contact stiffness, the nanoindentation stress-strain analysis, and the alpha-Ti crystal

orientations. Details of the samples and experimental protocols can be found in Weaver et al.

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